

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
201205US-2 DIVSERIAL NO.  
NEW DIV. APPLN.LIST OF REFERENCES CITED BY APPLICANT  
(Use Several Sheets if Necessary)APPLICANT  
Osamu FURUKAWA, et alFILING DATE  
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GROUP

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09/774047  
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE
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## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
AB	<del>JP 4-217333</del>	08/07/92	JAPAN	
AC	<del>JP 6-206293</del>	07/22/94	JAPAN	
AD	<del>JP 5-55505</del>	03/05/93	JAPAN	
AE	<del>JP 5-7424</del>	01/14/93	JAPAN	
AF	<del>JP 03-289308</del>	12/19/91	JAPAN	
AG	<del>JP 1-84752</del>	03/30/89	JAPAN	
AH	<del>JP 5-218230</del>	08/27/93	JAPAN	
AI	<del>JP 6-295937</del>	10/21/94	JAPAN	
AJ	<del>JP 7-58149</del>	03/03/95	JAPAN	
AK	<del>JP 53-129299</del>	11/11/78	JAPAN	
AL	<del>JP 5-345397</del>	11/26/93	JAPAN	
AM	<del>JP 62-205635</del>	09/10/87	JAPAN	
AN	<del>JP 56-52811</del>	07/25/81	JAPAN	
AO	<del>JP 5-206523</del>	08/13/93	JAPAN	
AP	<del>JP 6-151626</del>	05/31/94	JAPAN	
AQ	<del>JP 57-173563</del>	11/01/82	JAPAN	
AR	<del>JP 5-235203</del>	09/10/93	JAPAN	
AS	<del>JP 55-81125</del>	05/08/80	JAPAN	
AT	<del>JP 1-25428</del>	01/27/89	JAPAN	
AU	<del>JP 59-83735</del>	04/11/84	JAPAN	
AV	<del>JP 5-235688</del>	09/10/93	JAPAN	
AW	<del>JP 52-18147</del>	02/07/77	JAPAN	
AX	<del>JP 4-56510</del>	02/24/92	JAPAN	

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AY	Kagaku Daijiten (Chemical Dictionary), Maruzen K.K., page 1189, March 5, 1985
AZ	

EXAMINER

DATE CONSIDERED 10/28/03

\*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201210US-2 DIV		SERIAL NO. NEW DIV. APPL	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT OSAMU FURUKAWA, ET AL.			
				CPA FILED HEREWITH		GROUP 2834	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	<del>401193028</del>	05/89	Japan	<i>No</i>		
	AP	<del>04428438</del>	05/89	Japan			
	AQ				<i>Copies</i> <i>Received</i>		
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	AW	<i>Mr</i> <i>10/22/03</i>					
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